Notice of References Cited Application/Control No. 10/647,540 Examiner Alex Liew Applicant(s)/Patent Under Reexamination NAPHADE ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

Date **Document Number** Classification Name MM-YYYY Country Code-Number-Kind Code 382/117 US-6,714,665 03-2004 Hanna et al. US-В US-C US-D US-Ε US-US-G US-US-US-US-K US-

FOREIGN PATENT DOCUMENTS

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